

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination LEE, SHIH-LIN	
			Examiner R. Alexander Smith	Art Unit 2859	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-D486,085 S	02-2004	Lee, Shih-Lin	D10/72
	B	US-D485,770 S	01-2004	Lee, Shih-Lin	D10/72
	C	US-D447,712 S	09-2001	Hsu, Cheng-Hui	D10/72
	D	US-D438,478 S	03-2001	Lin, Ping-Nan	D10/72
	E	US-6,807,747 B1	10-2004	Hsu, Cheng-Hui	33/769
	F	US-6,718,649 B1	04-2004	Critelli et al.	33/761
	G	US-6,382,547 B1	05-2002	Yang, Tse-Chung	242/379
	H	US-6,276,071 B1	08-2001	Khachatoorian, Zareh	33/767
	I	US-6,216,356 B1	04-2001	Li, Shih Lin	33/768
	J	US-6,182,916 B1	02-2001	Lin, Henry	242/379
	K	US-5,746,004 A	05-1998	Wertheim, Gregory D.	33/768
	L	US-2003/0233762 A1	12-2003	Blackman et al.	33/769
	M	US-2002/0129509 A1	09-2002	Evans, John Joseph III	33/757

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.